

**ASC800N1200MED**

V X / Mob:15919711751

1200V SiC MOSFET Module

Features

- High Temperature, Humidity, and Bias Operation
- Ultra Low Loss
- High-Frequency Operation
- Zero Turn-off Tail Current from MOSFET
- Normally-off, Fail-safe Device Operation
- Ease of Paralleling
- AlN Substrate with Low Thermal Resistance
- Integrated NTC temperature sensor
- Copper Base Plate

Potential Applications

- High power converters
- Motor drives
- Servo drives
- UPS systems
- Wind turbines

Package 152mm x 62.5mm x 20.5mm

Part Number	Package	Marking
ASC800N1200MED	Econodual	ASC800N1200MED

Absolute Maximum Ratings ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit
V_{DS}	Drain-Source Voltage			1200	V
V_{GS}	Gate-Source Voltage	-10		+20	V
I_D	Drain Current(continuous) $V_{GS} = 20\text{V}$		800		A
I_{DM}	Drain Current (10us pulsed)		1600		A
P_D	Power Dissipation $T_C = 25^\circ\text{C}$			960	W
T_C, T_{stg}	Operating and Storage Temperature Range	-40		+150	°C
LStray	Stray Inductance			20	nH



ASC800N1200MED

Electrical Characteristics (T_C = 25°C unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV _{DS}	Drain-source Breakdown Voltage	I _D =3mA, V _{GS} =0V	1200			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =1200V, V _{GS} =0V		120	1200	uA
I _{GSS}	Gate-body Leakage Current	V _{GS} =-10/+20V, V _{DS} =0V		1	3	uA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D =240mA	2		4	V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} =20V, I _D =600A		2.2	3	mΩ
C _{iss}	Input Capacitance	V _{DS} =800V, ID=800A, V _{GS} =-4~20V		58		nF
C _{oss}	Output Capacitance			1.5		
C _{rss}	Reverse Transfer Capacitance			300		pF
E _{on}	Turn-On Switching Energy	V _{DD} =800V, V _{GS} =-4/+20V ID=600A, R _{G(ext)} =5Ω Load=157uH, T _J =25°C		14		mJ
E _{off}	Turn-Off Switching Energy			5		mJ
Q _{GS}	Gate-Source Charge	V _{DD} =800V, V _{GS} =-4/+15V ID=450A,		700		nC
Q _{GD}	Gate-Drain Charge			550		
Q _G	Total Gate Charge			2410		
t _{d(on)}	Turn-on delay time	V _{DD} =800V, V _{GS} =-4/+20V ID=600A,		155		nS
t _r	Rise Time			29		
t _{d(off)}	Turn-off delay time			79		
t _f	Fall Time			26		
V _{sd}	Diode Forward voltage	I _f =450A, V _{GS} =0			6	V

Thermal Characteristics

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	T _c =90°C, P _D =150W		0.13		°C/W

Typical Performance

Figure 1. Output Characteristics

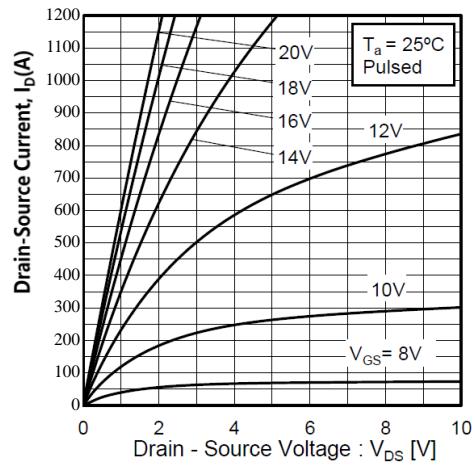


Figure 2. Normalized On-Resistance vs. Temperature

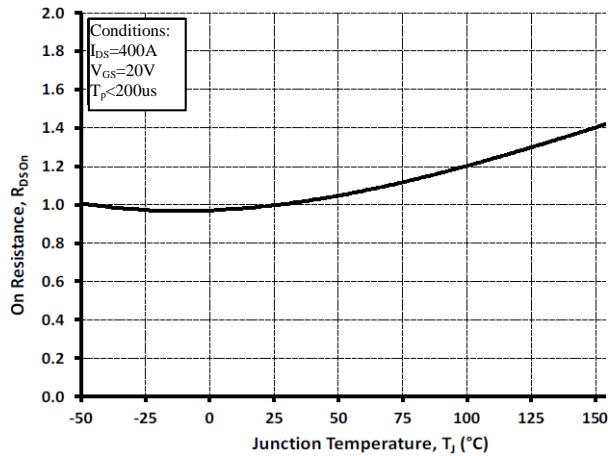


Figure 3. Threshold Voltage vs. Temperature

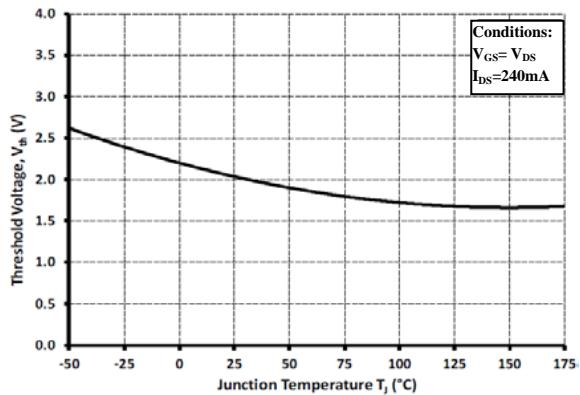


Figure 4. Transfer Characteristic for Various T_J

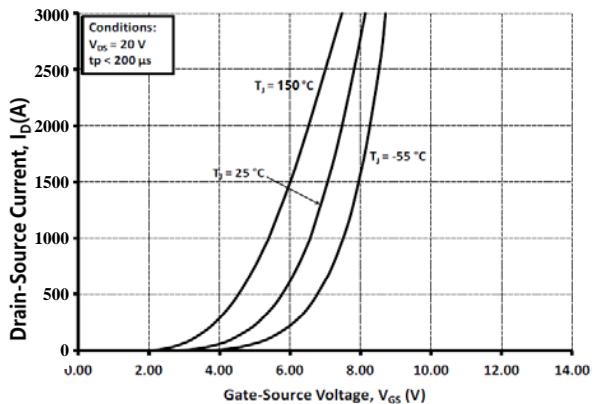


Figure 5. Diode Characteristic at 25 °C

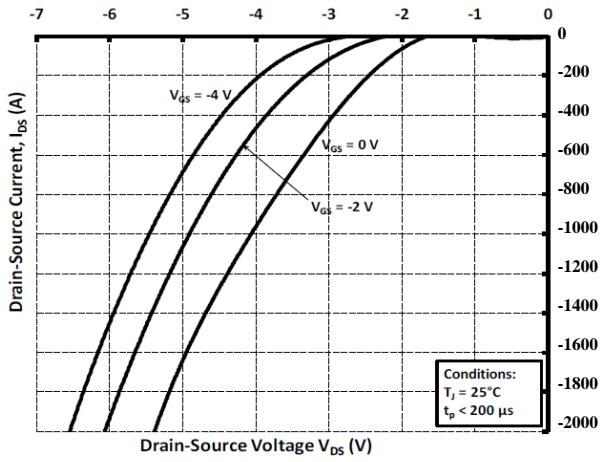


Figure 6. Typical Gate Charge Characteristics

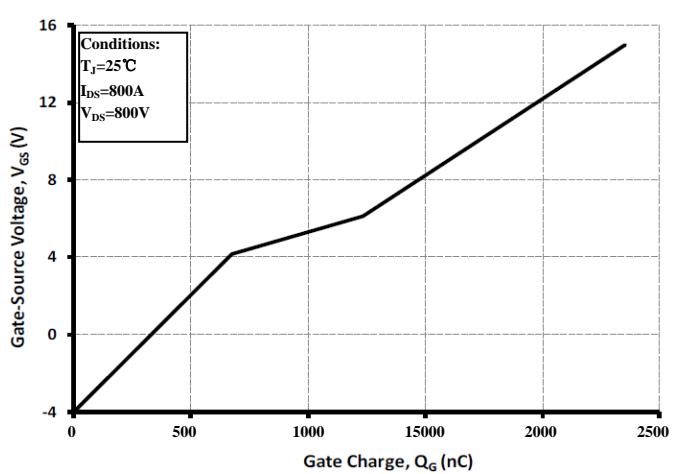


Figure 7. Typical Capacitances vs. Drain-Source Voltage

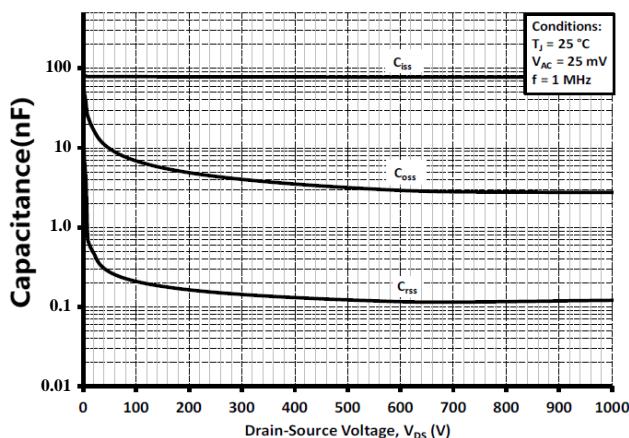


Figure 8. Inductive Switching Energy vs. $R_G(\text{ext})$

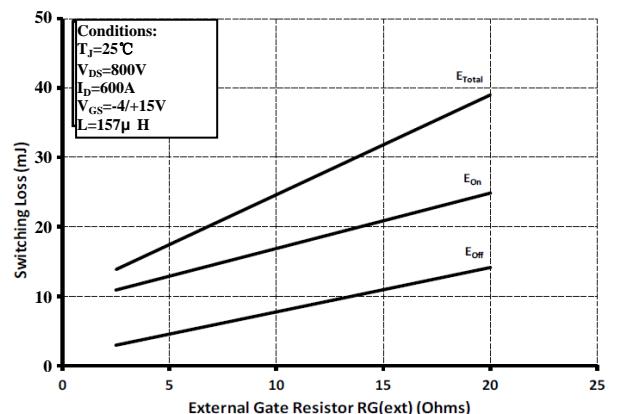


Figure 9. Resistive Switching Time Description

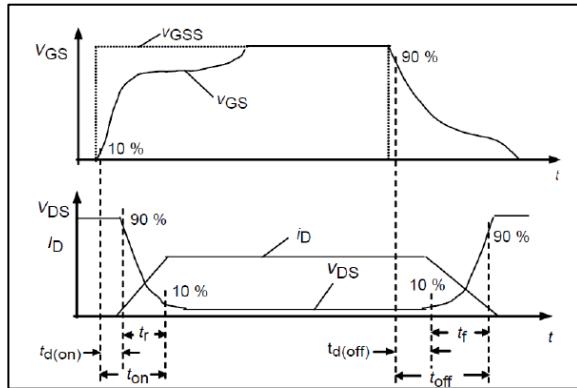
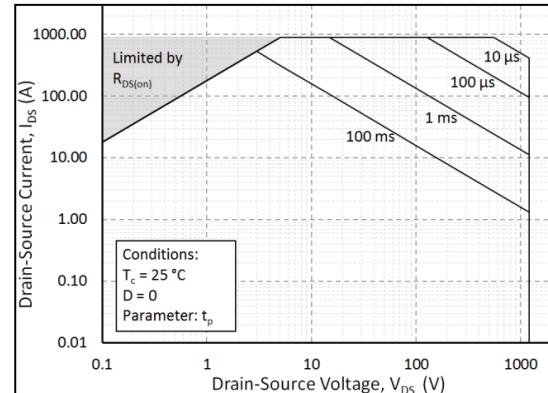
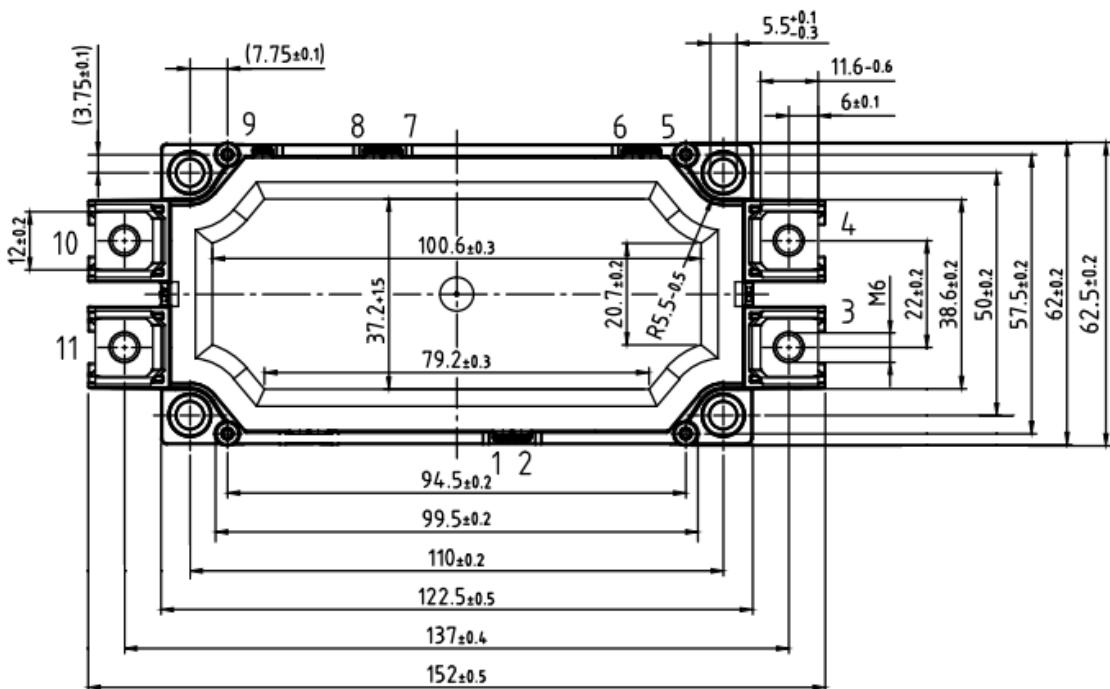
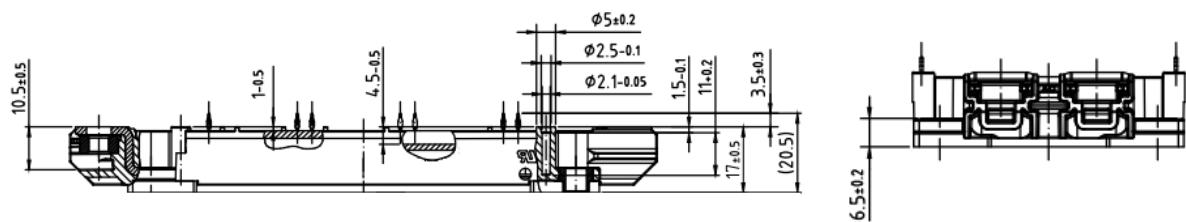
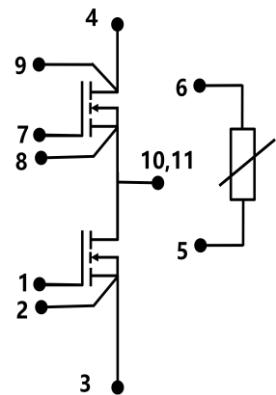
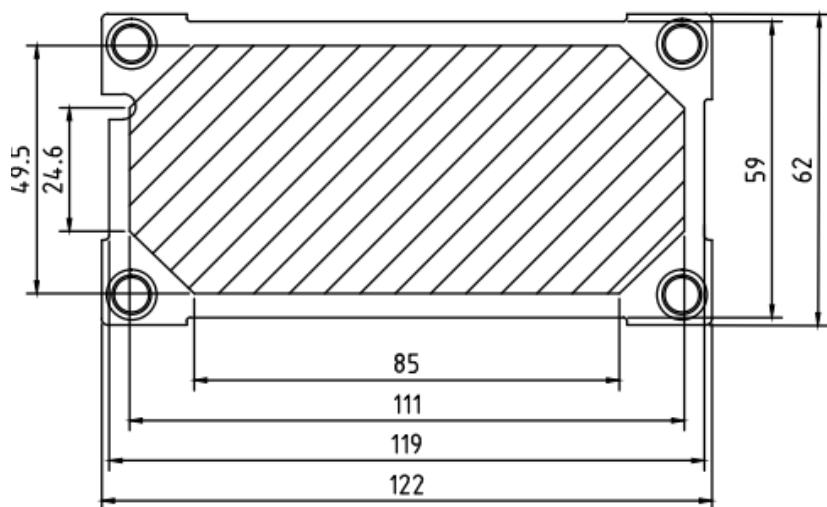


Figure 10. Safe Operating Area



Package Drawing:



**Econodual**